

MOTOROLA

SEMICONDUCTOR

TECHNICAL DATA

Designer's Data Sheet

Power Field Effect Transistor

P-Channel Enhancement

Mode Silicon Gate

DPAK for Surface Mount or Insertion Mount

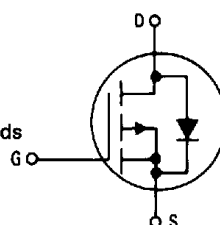


MTD4P06

TMOS POWER FET
4 AMPERES
 $R_{DS(on)} = 0.6 \text{ OHM}$
50 and 60 VOLTS

This TMOS Power FET is designed for high speed, low loss power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds
- Low $R_{DS(on)}$ — 0.6Ω max
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads
- Low Drive Requirement — $V_{GS(th)} = 4 \text{ V}$ max
- Surface Mount Package on 16 mm Tape
- Available With Long Leads, Add -1 Suffix



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	60	Vdc
Drain-Gate Voltage ($R_{GS} = 1 \text{ M}\Omega$)	V_{DGR}	60	Vdc
Gate-Source Voltage — Continuous	V_{GS}	± 20	Vdc
— Non-repetitive ($t_p \leq 50 \mu\text{s}$)	V_{GSM}	± 40	Vpk
Drain Current — Continuous	I_D	4	Adc
— Pulsed	I_{DM}	14	
Total Power Dissipation @ $T_C = 25^\circ\text{C}$	P_D	20	Watts
Derate above 25°C		0.16	W/ $^\circ\text{C}$
Total Power Dissipation @ $T_A = 25^\circ\text{C}$	P_D	1.25	Watts
Derate above 25°C		0.01	W/ $^\circ\text{C}$
Total Power Dissipation @ $T_A = 25^\circ\text{C}$ (1)	P_D	1.75	Watts
Derate above 25°C		0.014	W/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-65 to $+150$	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Thermal Resistance — Junction to Case	$R_{\theta JC}$	6.25	$^\circ\text{C/W}$
— Junction to Ambient	$R_{\theta JA}$	100	
— Junction to Ambient (1)		71.4	

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

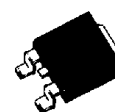
Characteristic	Symbol	Min	Max	Unit
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OFF CHARACTERISTICS

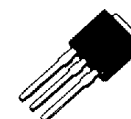
Drain-Source Breakdown Voltage ($V_{GS} = 0, I_D = 0.25 \text{ mA}$)	$V_{(BR)DSS}$	50	—	Vdc
		60	—	
Zero Gate Voltage Drain Current ($V_{DS} = 0.85 \text{ Rated } V_{DSS}, V_{GS} = 0$)	I_{DSS}	—	0.2	mAdc
$T_J = 125^\circ\text{C}$		—	1	

(1) These ratings are applicable when surface mounted on the minimum pad size recommended. (continued)

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.



CASE 369A-10
TO-252
MTD4P06



CASE 369-06
TO-251
MTD4P06-1

ELECTRICAL CHARACTERISTICS — continued ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS — continued				
Gate-Body Leakage Current, Forward ($V_{GSF} = 20\text{ Vdc}$, $V_{DS} = 0$)	I_{GSSF}	—	100	nAdc
Gate-Body Leakage Current, Reverse ($V_{GSR} = 20\text{ Vdc}$, $V_{DS} = 0$)	I_{GSSR}	—	100	nAdc

ON CHARACTERISTICS*

Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = 1\text{ mA}$) $T_J = 100^\circ\text{C}$	$V_{GS(th)}$	2 1.5	4.5 4	Vdc
Static Drain-Source On-Resistance ($V_{GS} = 10\text{ Vdc}$, $I_D = 2\text{ Adc}$)	$R_{DS(on)}$	—	0.6	Ohm
Drain-Source On-Voltage ($V_{GS} = 10\text{ V}$) ($I_D = 4\text{ Adc}$) ($I_D = 2\text{ Adc}$, $T_J = 100^\circ\text{C}$)	$V_{DS(on)}$	— —	2.4 2.4	Vdc
Forward Transconductance ($V_{DS} = 15\text{ V}$, $I_D = 2\text{ A}$)	g_{FS}	0.75	—	mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	$(V_{DS} = 25\text{ V}$, $V_{GS} = 0$, $f = 1\text{ MHz}$ See Figure 12)	C_{iss}	—	700	pF
Output Capacitance		C_{oss}	—	400	
Reverse Transfer Capacitance		C_{rss}	—	150	

SWITCHING CHARACTERISTICS* ($T_J = 100^\circ\text{C}$)

Turn-On Delay Time	$(V_{DD} = 25\text{ V}$, $I_D = 0.5\text{ Rated } I_D$ $R_{gen} = 50\text{ ohms}$ See Figures 10, 14 and 15)	$t_{d(on)}$	—	40	ns
Rise Time		t_r	—	120	
Turn-Off Delay Time		$t_{d(off)}$	—	80	
Fall Time		t_f	—	70	
Total Gate Charge	$(V_{DS} = 0.8\text{ Rated } V_{DSS}$, $I_D = \text{Rated } I_D$, $V_{GS} = 10\text{ V}$) See Figure 13	Q_g	12 (Typ)	16	nC
Gate-Source Charge		Q_{gs}	7 (Typ)	—	
Gate-Drain Charge		Q_{gd}	5 (Typ)	—	

SOURCE DRAIN DIODE CHARACTERISTICS*

Forward On-Voltage	$(I_S = \text{Rated } I_D$ $V_{GS} = 0)$	V_{SD}	1.8 (Typ)	5	Vdc
Forward Turn-On Time		t_{on}	Limited by stray inductance		
Reverse Recovery Time		t_{rr}	325 (Typ)	—	ns

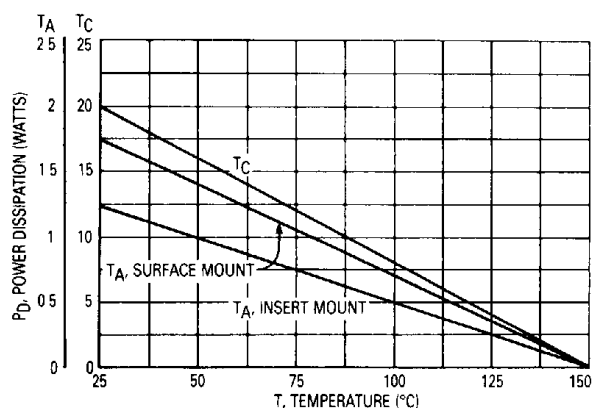
*Pulse Test: Pulse Width $\leq 300\text{ }\mu\text{s}$, Duty Cycle $\leq 2\%$ 

Figure 1. Power Derating

TYPICAL ELECTRICAL CHARACTERISTICS

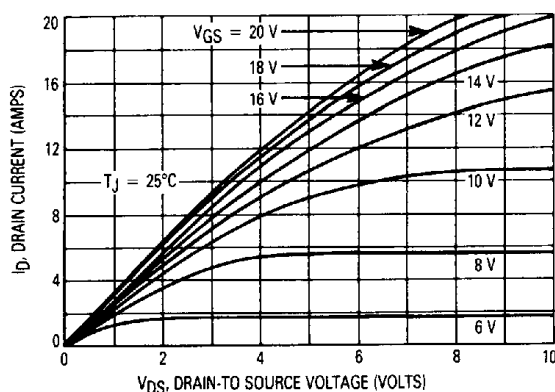


Figure 2. On-Region Characteristics

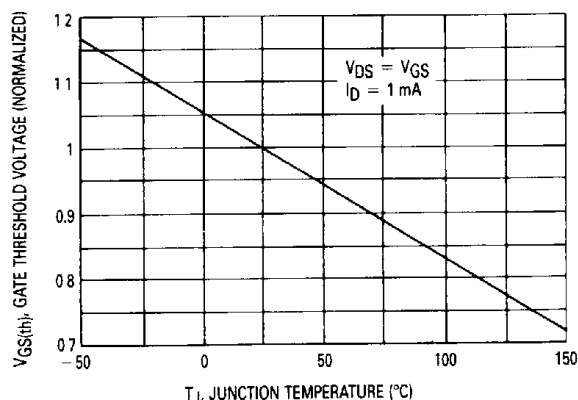


Figure 3. Gate-Threshold Voltage Variation With Temperature

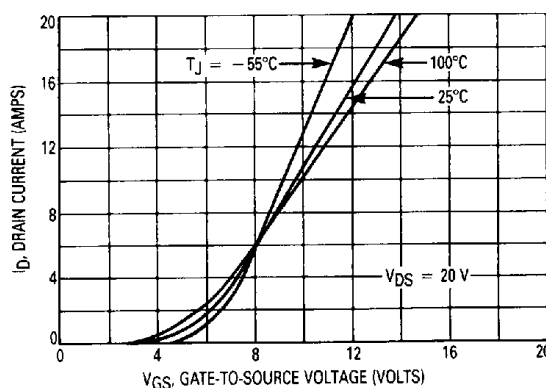


Figure 4. Transfer Characteristics

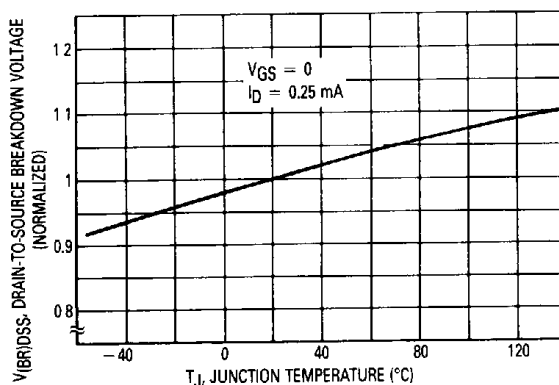


Figure 5. Breakdown Voltage Variation With Temperature

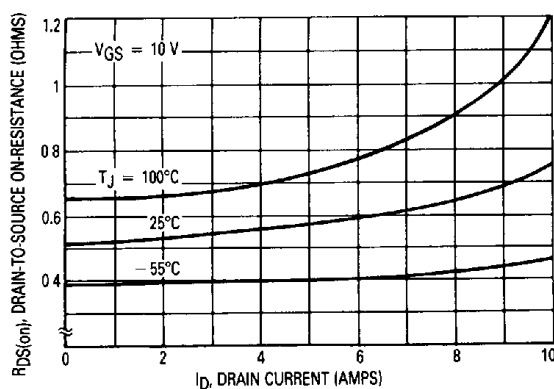


Figure 6. On-Resistance versus Drain Current

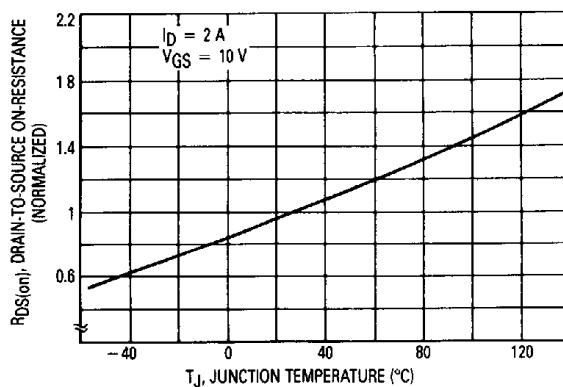


Figure 7. On-Resistance Variation With Temperature

SAFE OPERATING AREA INFORMATION

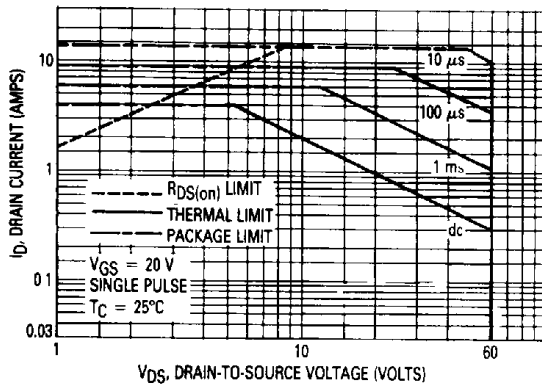


Figure 8. Maximum Rated Forward Bias Safe Operating Area

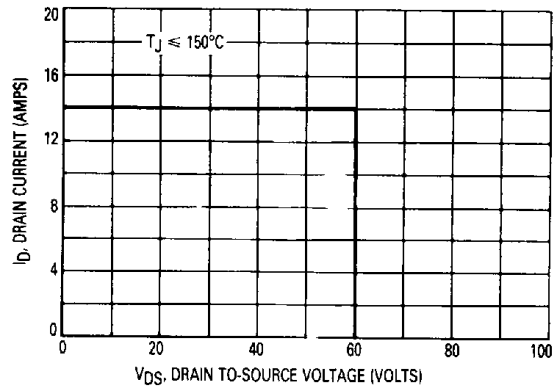


Figure 9. Maximum Rated Switching Safe Operating Area

FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 9 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, I_{DM} and the breakdown voltage, $V_{(BR)DSS}$. The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{T_{J(max)} - T_C}{R_{\theta JC}}$$

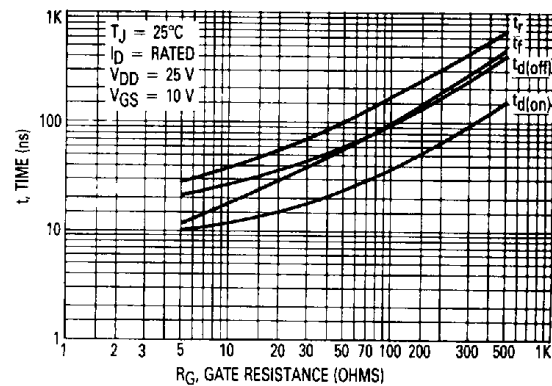


Figure 10. Resistive Switching Time Variation With Gate Resistance

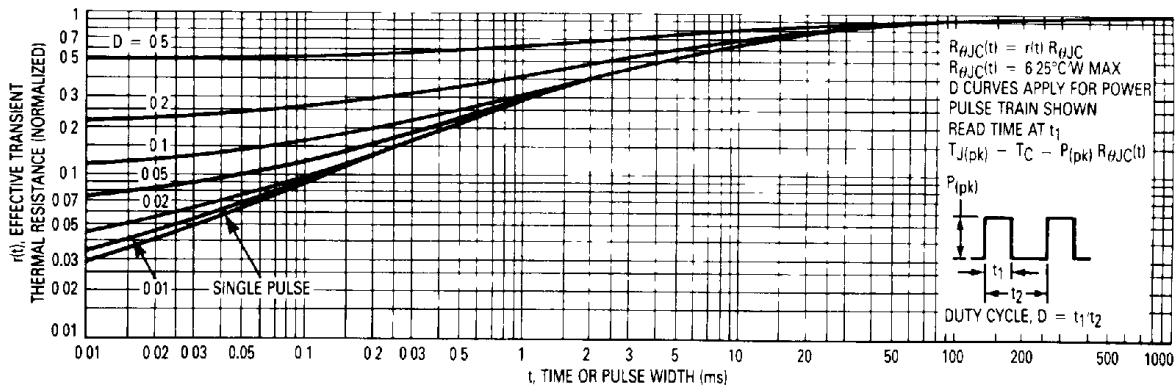


Figure 11. Thermal Response

TYPICAL CHARACTERISTICS

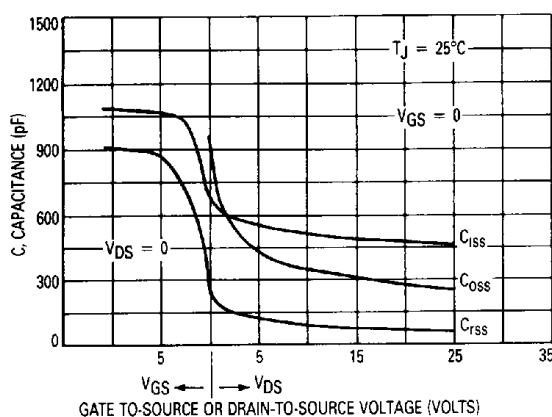


Figure 12. Capacitance Variation

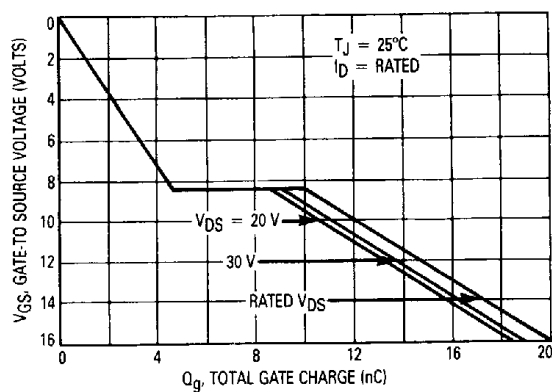


Figure 13. Gate Charge versus Gate-To-Source Voltage

RESISTIVE SWITCHING

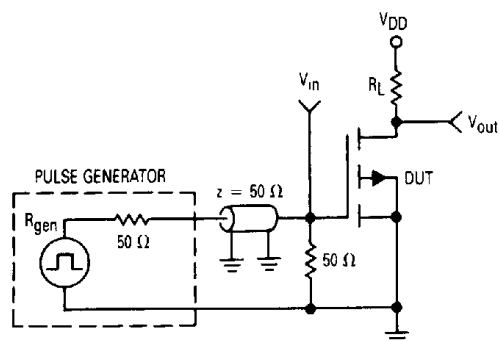


Figure 14. Switching Test Circuit

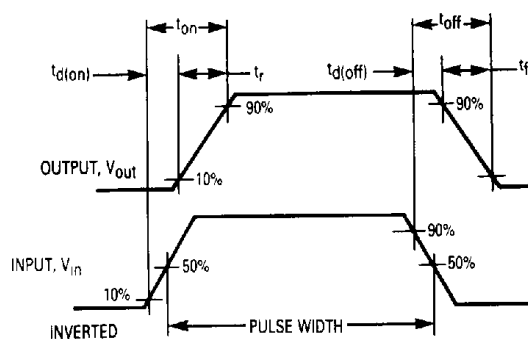


Figure 15. Switching Waveforms